Page : 15 of 22 Issued date : May 27, 2008 Revised date : June 3, 2008

FCC ID : WAZX1T763SKE11A04

# **APPENDIX 2: Data of EMI test**

# **Automatically deactivate**

UL Japan, Inc.

Head Office EMC Lab. No.4 Semi Anechoic Chamber

COMPANY: Mitsubishi Erectric Corporation Himeji Works REPORT NO: 28GE0141-HO-01 EQUIPMENT: SMART KEYLESS SYSTEM (TRANSMITTER) REGULATION: FCC15.231(a)(1)

MODEL : SKE11A-04 TEST DISTANCE : -

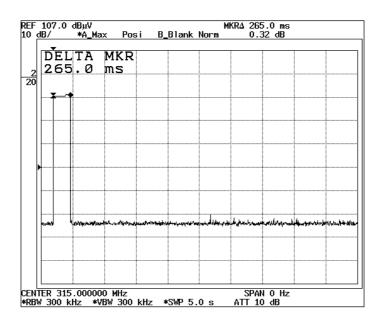
 S/N
 : 20080327-02
 DATE
 : 03/31/2008

 POWER
 : DC 3.0V
 TEMPERATURE
 : 24 deg.C.

 Mode
 : Normal use mode
 HUMIDITY
 : 41%

Axis :- ENGINEER : Shinya Watanabe

Time of	Limit	Result
Transmitting		
[sec]	[sec]	
0.27	5.00	Pass



# UL Japan, Inc.

### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 16 of 22 Issued date : May 27, 2008 Revised date : June 3, 2008

FCC ID : WAZX1T763SKE11A04

# Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

UL Japan, Inc.

REPORT NO

Head Office EMC Lab. No.4 Semi Anechoic Chamber

28GE0141-HO-01

COMPANY : Mitsubishi Electric Coporation Himeji Works
EOUIPMENT : SMART KEYLESS SYSTEM (TRANSMITTER)

 : SMART KEYLESS SYSTEM (TRANSMITTER)
 REGULATION
 : FCC Part15 Subpart C 15.231(b) / 15.205 / 15.209

 : SKE11A-04
 TEST DISTANCE
 : 3m

 : 20080327-05
 DATE
 : 03/31/2008

 : DC 3.0V
 TEMPERATURE
 : 24 deg.C.

 Mode
 : Transmitting mode
 HUMIDITY
 : 41%

 EUT Axis
 : Hor.: X-axis , Ver.: Z-axis
 ENGINEER
 : Shinya Watanabe

QP DETECT

MODEL

POWER

S/N

QI DI	EILCI											
No.	FREQ	T/R RE	ADING	ANT	AMP	LOSS	Duty	RES	ULT	Limit	MAF	RGIN
		HOR	VER	Factor	GAIN		Factor	HOR	VER		HOR	VER
	[MHz]	[dE	BuV]	[dB/m]	[dB]	[dB]	[dB]	[dBu	[dBuV/m]		[dB]	[dB]
1	315.00	78.9	74.3	16.9	32.0	10.0	-	73.8	69.2	75.6	1.8	6.4
2	630.00	23.2	23.7	20.5	32.1	12.0	-	23.6	24.1	55.6	32.0	31.5
3	945 00	22.2	22.3	25.1	31.0	13.5		29.8	29 9	55.6	25.8	25.7

PK DI	ETECT	(RBW: 1MF	Iz, VBW: 1M	(Hz)		(Inside Restricted bands)						
No.	FREQ	FREQ S/A READING		ANT	AMP	LOSS	Duty	RESULT		Limit	MARGIN	
		HOR	VER	Factor	GAIN		Factor	HOR	VER		HOR	VER
	[MHz]	[dB	uV]	[dB/m]	[dB]	[dB]	[dB]	[dBu	[dBuV/m]		[dB]	[dB]
5	1575.00	50.2	55.3	25.6	33.2	2.4	-	45.0	50.1	73.9	28.9	23.8
7	2205.00	53.6	52.0	26.5	32.3	2.7	-	50.5	48.9	73.9	23.4	25.0
9	2835.00	50.9	48.4	27.8	31.9	3.1	ı	49.9	47.4	73.9	24.0	26.5
4 X7 (D	V (DV DETECT)  Deadle Deadle (DDW, 1MIL VDW, 10IL)  (Inside Deadle Deadl											

AV (F	K DETECT,		Result – Rea	unig (KDW.	INITIZ, V D W	. 1011Z)		(mside Restricted bands)				
No.	FREQ	S/A READING		ANT	AMP	LOSS	Duty	RESULT		Limit	MAF	RGIN
		HOR	VER	Factor	GAIN		Factor	HOR	VER		HOR	VER
	[MHz]	[dB	uV]	[dB/m]	[dB]	[dB]	[dB]	[dBu	V/m]	[dBuV/m]	[dB]	[dB]
5	1575.00	45.6	49.5	25.6	33.2	2.4	-	40.4	44.3	53.9	13.5	9.6
7	2205.00	51.2	48.7	26.5	32.3	2.7	-	48.1	45.6	53.9	5.8	8.3
9	2835.00	46.3	42.1	27.8	31.9	3.1	-	45.3	41.1	53.9	8.6	12.8

PK D	ETECT		Result = Rea	ding (RBW:	lMHz , VBW	: 1MHz)		(Outside Restricted bands)				
No.	FREQ	S/A READING		ANT	AMP	LOSS	Duty	RESULT		Limit	MAI	RGIN
		HOR	VER	Factor	GAIN		Factor	HOR	VER		HOR	VER
	[MHz]	[dB	uV]	[dB/m]	[dB]	[dB]	[dB]	[dBu	V/m]	[dBuV/m]	[dB]	[dB]
4	1260.00	46.9	50.9	25.1	33.9	2.2	-	40.3	44.3	75.6	35.3	31.3
6	1890.00	46.2	42.9	25.9	32.7	2.6	-	42.0	38.7	75.6	33.6	36.9
8	2520.00	53.1	51.5	27.3	32.1	2.9	-	51.2	49.6	75.6	24.4	26.0
10	3150.00	49.2	48.7	28.2	31.7	3.2	-	48.9	48.4	75.6	26.7	27.2

1	AV (P	K DETECT)		Result = Rea	ding (RBW:	1MHz , VBW	: 10Hz)		(Outside Restricted bands)				
ſ	No.	FREQ	S/A READING		ANT	AMP	LOSS	Duty	RESULT		Limit	MARGIN	
			HOR	VER	Factor	GAIN		Factor	HOR	VER		HOR	VER
L		[MHz]	[dB	uV]	[dB/m]	[dB]	[dB]	[dB]	[dBu	V/m]	[dBuV/m]	[dB]	[dB]
ľ	4	1260.00	38.2	46.6	25.1	33.9	2.2	-	31.6	40.0	55.6	24.0	15.6
Γ	6	1890.00	37.4	44.1	25.9	32.7	2.6	-	33.2	39.9	55.6	22.4	15.7
Г	8	2520.00	50.5	47.1	27.3	32.1	2.9	-	48.6	45.2	55.6	7.0	10.4
Г	10	3150.00	44.1	41.8	28.2	31.7	3.2	-	43.8	41.5	55.6	11.8	14.1

REMARKS ANTENNA TYPE:30-300MHz Biconical / 300-1000MHz Logperiodic / 1-3.2GHz Horn

CALCULATION RESULT=Reading + ANT Factor - Amp Gain + LOSS (Cable+ ATTEN.)+Duty factor Duty cycle Factor Measurement :

ty cycle Factor Measurement : 0.0 dB

- \*The test above 1GHz was performed with PK DETECT (RBW: 1MHz, VBW: 1MHz) and AV (PK DETECT [RBW: 1MHz, VBW: 10Hz]).
- \*Duty Factor was calculated with the assumption of the worst condition in 100msec.
- \* The result is rounded off to the second decimal place, so some differences might be observed.
- \*The limit was converted from V to dBuV, and it is rounded off to the second decimal place.
- \*Except for the above table : All other spurious emissions were less than 20dB for the limit.

The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined. With the position, the noise levels of all the frequencies was measured.

## UL Japan, Inc.

#### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 17 of 22 Issued date : May 27, 2008 Revised date : June 3, 2008

FCC ID : WAZX1T763SKE11A04

# -20dB Bandwidth

UL Japan, Inc.

Head Office EMC Lab. No.4 Semi Anechoic Chamber

COMPANY : Mitsubishi Electric Coporation Himeji Works REPORT NO : 28GE0141-HO-01 EQUIPMENT : SMART KEYLESS SYSTEM (TRANSMITTER) REGULATION : FCC15.231(c)

MODEL : SKE11A-04 TEST DISTANCE : 3m

 S/N
 : 20080327-05
 DATE
 : 03/31/2008

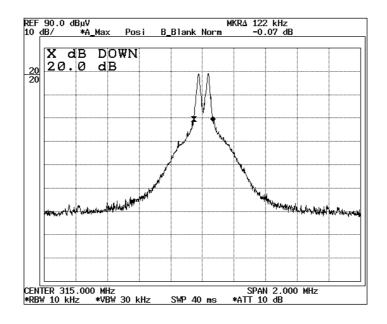
 POWER
 : DC 3.0V
 TEMPERATURE
 : 24 deg.C.

 Mode
 : Transmitting mode
 HUMIDITY
 : 41%

Axis : Hol.: X-axis ENGINEER : Shinya Watanabe

Bandwidth Limit: Fundamental Frequency 315 MHz X 0.25% = 787.50 kHz

-20dB Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
122.00	787.50	Pass



# UL Japan, Inc.

### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 18 of 22 Issued date : May 27, 2008 Revised date : June 3, 2008

FCC ID : WAZX1T763SKE11A04

# 99% Occupied Bandwidth

UL Japan, Inc.

Head Office EMC Lab. No.4 Semi Anechoic Chamber

COMPANY : Mitsubishi Electric Coporation Himeji Works REPORT NO : 28GE0141-HO-01 EQUIPMENT : SMART KEYLESS SYSTEM (TRANSMITTER) REGULATION : RSS-210 A1.1.3

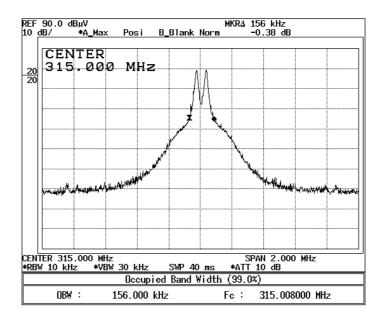
MODEL : SKE11A-04 TEST DISTANCE : 3m

S/N : 20080327-05 DATE : 03/31/2008 POWER : DC 3.0V TEMPERATURE : 24 deg.C. Mode : Transmitting mode HUMIDITY : 41%

Axis : Hol.: X-axis ENGINEER : Shinya Watanabe

Bandwidth Limit: Fundamental Frequency 315 MHz X 0.25% = 787.5 kHz

99% Occupied Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
156.00	787.50	Pass



# UL Japan, Inc.

### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Page : 19 of 22 Issued date : May 27, 2008 Revised date : June 3, 2008

FCC ID : WAZX1T763SKE11A04

# **Duty Cycle(Fundamental)**

UL Japan, Inc.

Head Office EMC Lab. No.4 Semi Anechoic Chamber

COMPANY : Mitsubishi Electric Coporation Himeji Works REPORT NO : 28GE0141-HO-01 EQUIPMENT : SMART KEYLESS SYSTEM (TRANSMITTER) REGULATION : FCC 15.231(b) / 15.35(e)

MODEL : SKE11A-04 TEST DISTANCE : -

 S/N
 : 20080327-02
 DATE
 : 03/31/2008

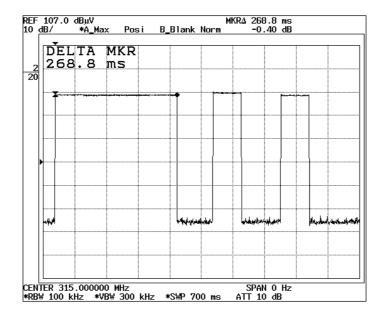
 POWER
 : DC 3.0V
 TEMPERATURE
 : 24 deg.C

 Mode
 : Transmitting mode
 HUMIDITY
 : 41%

Axis : Hol.: X-axis ENGINEER : Shinya Watanabe

ON time	Cycle	Duty	Duty
[ms]	[ms]	(On time/Cycle)	[dB]
100.00	100.00	1.00	0.0

\*3)Duty =  $20\log_{10}(ON \text{ time/Cycle})$ 



# UL Japan, Inc.

### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

 Page
 : 20 of 22

 Issued date
 : May 27, 2008

 Revised date
 : June 3, 2008

FCC ID : WAZX1T763SKE11A04

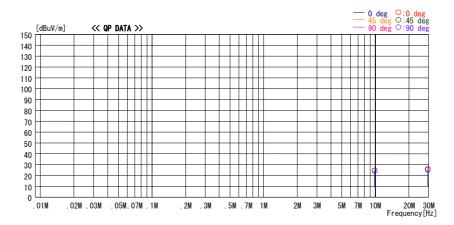
# Receiver Spurious Emission (Reference data)

DATA OF RADIATED EMISSION TEST

UL Japan, Inc. Head Office EMC Lab. No.1 Semi Anechoic Chamber Date: 2008/04/14

Company : Mitsubishi Electric Corporation Himeji Works Report No. : 28GE0141-H0-01 Kind of EUT Model No. : SMRT KEYLESS SYSTEM (TRANSMITTER) Power Power | Pow

Mode / Remarks : LF Receiving Mode



Freq.	Reading	DET	Ant. Fac	Loss	Gain	Result	Limit	Margin	Antenna	Table	Comment
[MHz]	[dBuV]		[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]		[deg]	
9.84400		QP	20. 3		38. 2	24. 6	-	-	0deg	0	
9.84400			20. 3	1. 0	38. 2	24. 6	-	-	45deg	0	
9. 84400			20. 3			24. 6	-	-	90deg	0	
29. 53130			21. 1	1. 8	38. 2	26. 1	-	-	0deg	0	
29. 53130			21. 1	1. 8	38. 2	25. 5	-	-	45deg	0	
29. 53130	40. 7	QP	21. 1	1. 8	38. 2	25. 4	-	-	90deg	0	
		l									
		l									
		l									
		l									
		l									
		l									
		l									
		l									
		l	1								
	l	I	1	- 1							I

CHART: WITH FACTOR, ANT TYPE: LOOP, Except for the data below: adequate margin data below the limits. CALCULATION: READING + ANT FACTOR + LOSS (CABLE + ATTEN.-AMP.)

# UL Japan, Inc. Head Office EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

<sup>\*</sup>The test result is rounded off to one or two decimal places, so some differences might be observed.

: 28GE0141-HO-01-A-R1 Test report No.

: 21 of 22 Page

Issued date : May 27, 2008 : June 3, 2008 Revised date

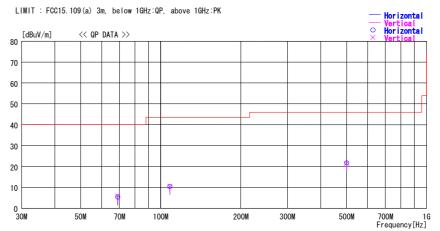
FCC ID : WAZX1T763SKE11A04

# **Receiver Spurious Emission**

DATA OF RADIATED EMISSION TEST
UL Japan, Inc. Head Office EMC Lab. No. 1 Semi Anechoic Chamber Date: 2008/04/14

Mitsubishi Electric Corporation Himeji Works
Smart Keyless System (Transmitter)
SKE11A-04
SCCCCCCC CC
Operator
Operator Company Kind of EUT Model No. Serial No. : 28GE0141-H0-01 : DC 3V : 22eg.C. / 53% : Shinya Watanabe

Mode / Remarks : LF Receiving mode



Frequency	Reading	DET	Antenna Factor	Loss& Gain	Level	Polar,	Limit	Margin
[MHz]	[dBuV]		[dB/m]	[dB]	[dBuV/m]		[dBuV/m]	[dB]
68. 906	22. 9	QP	6.8	-24. 3	5. 4	Hori.	40. 0	34. 6
68. 906	23. 4	QP	6.8	-24. 3	5. 9	Vert.	40. 0	34. 1
108. 281	23. 0	QP	11. 2	-23. 7	10. 5		43. 5	
108. 281	22. 9	QP	11. 2	-23. 7	10.4		43. 5	
500.000		QP	19.4	-20, 8	21. 7	Hori.	46. 0	
500.000	22. 8	QP	19.4	-20.8	21. 4	Vert.	46. 0	24. 6

CHART:WITH FACTOR ANT TYPE: -30MHz LOOP, 30-300MHz BICONICAL, 300MHz-1000MHz LOGPERIODIC, 1000MHz- HORN CALCULATION:RESULT = READING + ANT FACTOR + LOSS (CABLE+ATTEN.) - GAIN (AMP)

# UL Japan, Inc.

**Head Office EMC Lab.** 

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

<sup>\*</sup>The test result is rounded off to one or two decimal places, so some differences might be observed.

Page : 22 of 22 Issued date : May 27, 2008

Revised date : June 3, 2008 FCC ID : WAZX1T763SKE11A04

# **APPENDIX 3:Test Instruments**

**EMI** test equipment

Control No.	Instrument	Manufacturer	Model No	Test Item	Calibration Date * Interval(month)
MAEC-04	Anechoic Chamber	TDK	Semi Anechoic	RE	2008/03/27 * 12
			Chamber 3m		
MTR-07	Test Receiver	Rohde & Schwarz	ESCI	RE	2007/09/14 * 12
MSA-05	Spectrum Analyzer	Advantest	R3273	RE	2007/06/01 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	RE	2008/01/12 * 12
MLA-08	Logperiodic Antenna	Schwarzbeck	UKLP9140-A	RE	2008/01/12 * 12
MAT-31	Attenuator(6dB)	TME	UFA-01	RE	2008/03/10 * 12
MCC-50	Coaxial cable	UL Japan	-	RE	2008/03/17 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	RE	2008/03/06 * 12
MHA-21	Horn Antenna 1- 18GHz	Schwarzbeck	BBHA9120D	RE	2007/08/16 * 12
MCC-57	Microwave Cable 1G- 26.5GHz	Suhner	SUCOFLEX104	RE	2008/03/05 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	RE	2008/03/13 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	RE	2008/01/10 * 12
MJM-09	Measure	KDS	E19-55	RE	-
MSTW-14	EMI measurement program	TSJ	TEPTO-DV	RE	-
MAEC-01	Anechoic Chamber	TDK	Semi Anechoic Chamber 10m	RE	2007/11/23 * 12
MLPA-01	Loop Antenna	Rohde & Schwarz	HFH2-Z2	RE	2007/11/06 * 12
MCC-30	Coaxial cable	UL Japan	-	RE	2007/06/04 * 12
MCC-03	Coaxial Cable	Fujikura/Suhner/Agil ent/TSJ	-	RE	2007/12/27 * 12
MPA-19	Pre Amplifier	MITEQ	MLA-10K01-B01-35	RE	2008/02/13 * 12
MTR-01	Test Receiver	Rohde & Schwarz	ESI40	RE	2007/10/19 * 12
MOS-01	Digital Humidity Indicator	N.T	NT-1800	RE	2007/11/12 * 12
MJM-01	Measure	KDS	ES19-55	RE	-
MBA-01	Biconical Antenna	Schwarzbeck	BBA9106	RE	2007/10/21 * 12
MLA-09	Logperiodic Antenna	Schwarzbeck	USLP9143B	RE	2008/01/12 * 12
MAT-06	Attenuator(6dB)	Weinschel Corp	2	RE	2007/11/14 * 12
MCC-01 Coaxial Cable 0.1- 3000MHz		Suhner/storm/Agilent/ TSJ	-	RE	2008/02/29 * 12
MPA-04 Pre Amplifier Agi		Agilent	8447D	RE	2007/07/11 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with traceable calibrations. Each calibration is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

**Test Item:** 

**RE: Radiated emission** 

# UL Japan, Inc.

### **Head Office EMC Lab.**

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN